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October 2014

FDMS7556S

N-Channel PowerTrench[®] SyncFETTM 25 V, 130 A, 1.2 m Ω

Features

- Max $r_{DS(on)} = 1.2 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 35 \text{ A}$
- Max $r_{DS(on)} = 1.65 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 31 \text{ A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

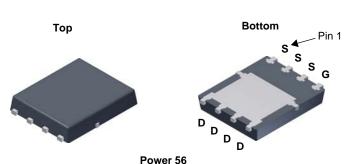


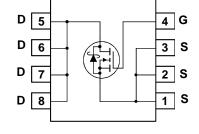
General Description

The FDMS7556S has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{\text{DS}(\text{on})}$ while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

Applications

- Synchronous Rectifier for Synchronous Buck Converters
- Notebook
- Server
- Telecom
- High Efficiency DC-DC Switch Mode Power Supplies





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MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			25	V
V_{GS}	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		130	
	-Continuous (Silicon limited)	T _C = 25 °C		222	A
ID	-Continuous	T _A = 25 °C	(Note 1a)	35	A
	-Pulsed			200	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	312	mJ
В	Power Dissipation	T _C = 25 °C		96	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7556S	FDMS7556S	Power 56	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V	25			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25 °C		22		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 20 V, V _{GS} = 0 V			500	μΑ
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1 \text{ mA}$	1.2	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 10 mA, referenced to 25 °C		-5		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 35 A		0.95	1.2	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D = 31 \text{ A}$		1.3	1.65	
		$V_{GS} = 10 \text{ V}, I_D = 35 \text{ A}, T_J = 125 ^{\circ}\text{C}$		1.2	1.6	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 35 A		212		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 42.V V 0.V	6740	8965	pF
Coss	Output Capacitance	$V_{DS} = 13 \text{ V}, V_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$	1940	2580	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12	314	475	pF
R_{q}	Gate Resistance		0.6	1.3	Ω

Switching Characteristics

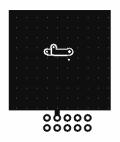
t _{d(on)}	Turn-On Delay Time		20	36	ns
t _r	Rise Time	V _{DD} = 13 V, I _D = 35 A,	9	18	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	48	77	ns
t _f	Fall Time		5.3	11	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	95	133	nC
Q_g	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} V_{DD} = 13 \text{ V}$	43	60	nC
Q _{gs}	Gate to Source Gate Charge	I _D = 35 A	18.6		nC
Q_{gd}	Gate to Drain "Miller" Charge		8.8		nC

Drain-Source Diode Characteristics

V _{SD}	Source to Drain Dioge Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 2 \text{ A}$ (Note 2)	0.37	0.7	V
		$V_{GS} = 0 \text{ V}, I_S = 35 \text{ A}$ (Note 2)	0.74	1.2	
t _{rr}	Reverse Recovery Time	-I _E = 35 A, di/dt = 300 A/μs	44	71	ns
Q _{rr}	Reverse Recovery Charge	-1 _F = 35 A, α/αι = 300 A/μs	68	109	nC

Notes:

^{1.} R_{0,1A} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,1C} is guaranteed by design while R_{0,1C} is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



 b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

^{2.} Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.

^{3.} E_{AS} of 312 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 25 A, V_{DD} = 23 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 38 A.

^{4.} As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

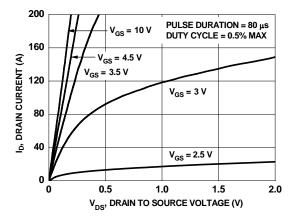


Figure 1. On-Region Characteristics

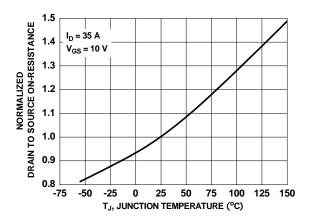


Figure 3. Normalized On-Resistance vs Junction Temperature

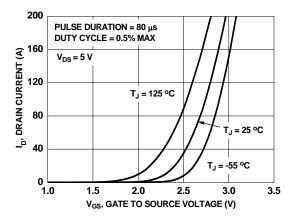


Figure 5. Transfer Characteristics

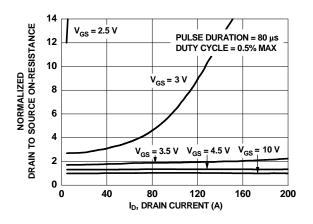


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

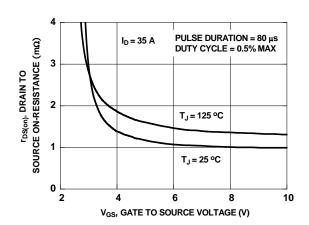


Figure 4. On-Resistance vs Gate to Source Voltage

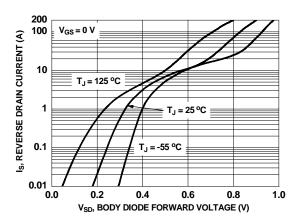


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

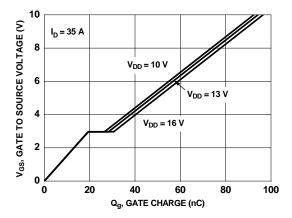


Figure 7. Gate Charge Characteristics

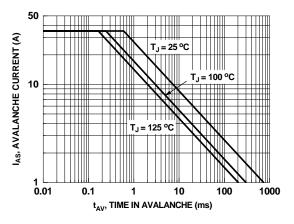


Figure 9. Unclamped Inductive Switching Capability

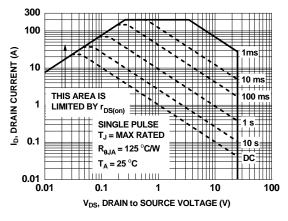


Figure 11. Forward Bias Safe Operating Area

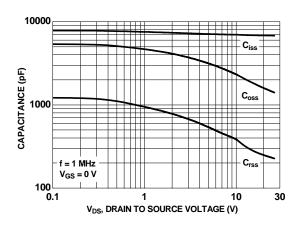


Figure 8. Capacitance vs Drain to Source Voltage

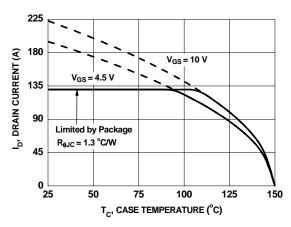


Figure 10. Maximum Continuous Drain Current vs Case Temperature

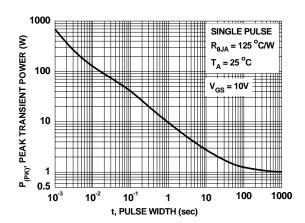
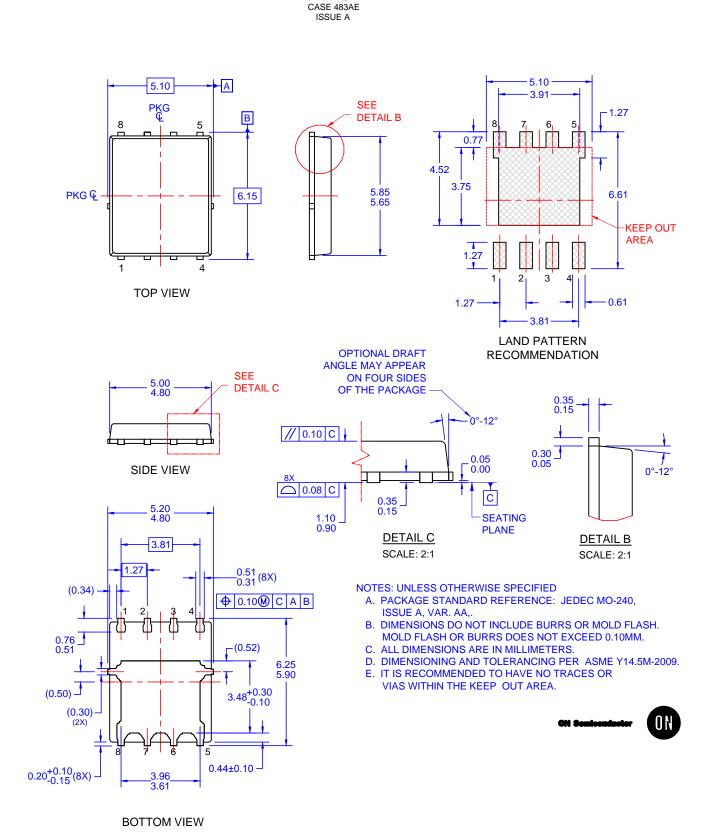


Figure 12. Single Pulse Maximum Power Dissipation



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